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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: ) PATENT  
Herbert THANNER et al. )  
Serial No.: 10/086,537 ) GROUP: 1751  
Filed: March 4, 2002 ) EXAMINER: To be assigned  
PIEZOELECTRIC SINGLE CRYSTAL )  
ELEMENT )

\* \* \* \* \*

INFORMATION DISCLOSURE STATEMENT

Honorable Director for Patents  
Washington, D.C. 20231

Washington, D.C.  
January 29, 2003

Sir:

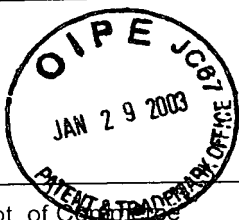
The inventors herewith submit a copy of an International Search  
Report issued relative to a counterpart PCT application, as well as copies  
of the documents identified therein.

Respectfully submitted,

DYKEMA GOSSETT PLLC

By:

Richard H. Tushin  
Registration No. 27,297  
Franklin Square, Third Floor West  
1300 I Street N.W.  
Washington, DC 20005-3353  
(202) 906-8600



(January 29, 2003)

Sheet 1 of 2

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**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE

**FOREIGN PATENT DOCUMENTS**

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES NO	

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, etc.)

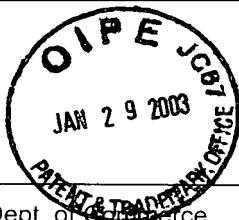
	<b>C. Reiter et al., "Elastic Constants and Temperature-Compensated Orientations of GaPO<sub>4</sub>," 15<sup>th</sup> European Frequency and Time Forum Neuchatel, XP008009573, 6 March 2001, pp. 50-54.</b>
	<b>E. Philippot et al., "A Quartz-like Material...Characterization" in J. Crystal Growth, 130, No. 1/2, May 1993, pp. 195-208.</b>
	<b>A. Zarka et al., "Studies of GaPO<sub>4</sub> Crystals and Resonators," 1996 IEEE International Frequency Control Symposium, 1996, pp. 66-71.</b>

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Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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	<b>S.A. Ssakharov et al., "Application of Langasite...Modes," 1992 IEEE Frequency Control Symposium, 1992, pp. 713-723.</b>
	<b>H. Fritze et al., "High Temperature...Langasite" in Sensors and Actuators B 76, 1 June 2001, pp. 103-107.</b>
	<b>M. F. Dubovik et al., "Influence...Crystals," 1996 IEEE International Frequency Control Symposium, 1996, pp. 84-89.</b>

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